

Notice of References Cited	Application/Control No. 10/715,391	Applicant(s)/Patent Under Reexamination ITOH, TERUAKI	
	Examiner Brian R. Gordon	Art Unit 1743	Page 1 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,028,831	04-2006	Veiner, Craig R.	198/619
*	B	US-6,866,820	03-2005	Otto et al.	422/63
*	C	US-6,444,171	09-2002	Sakazume et al.	422/65
*	D	US-6,261,521	07-2001	Mimura et al.	422/67
*	E	US-6,019,945	02-2000	Ohishi et al.	422/65
*	F	US-5,207,986	05-1993	Kadota et al.	422/65
*	G	US-5,008,082	04-1991	Shaw, James D.	422/65
*	H	US-2003/0081924	05-2003	Sasaki et al. 2003/0081924	422/82.09
*	I	US-6,936,474	08-2005	Chiou et al.	436/180
*	J	US-6,916,447	07-2005	Kowallis, Reid Burton	422/66
*	K	US-6,599,476	07-2003	Watson et al.	422/63
*	L	US-6,495,360	12-2002	Kercso et al.	436/47
*	M	US-6,461,570	10-2002	Ishihara et al.	422/65

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.